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Pages:118 - 123

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Pages:224 - 229

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Pages:670 - 678

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Pages:1302 - 1305

[\[Abstract\]](#) [\[PDF Full-Text \(152 KB\)\]](#) IEEE JNL

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Pages:504 - 511

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Pages:512 - 519

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Pages:318 - 324

[\[Abstract\]](#)   [\[PDF Full-Text \(376 KB\)\]](#)   [IEEE JNL](#)

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[1](#) [2](#) [3](#) [4](#) [5](#) [6](#) [7](#) [8](#) [9](#) [10](#) [11](#) [12](#) [13](#) [14](#) [15](#) [16](#) [17](#) [18](#) [19](#) [20](#) [21](#) [22](#) [23](#)  
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